## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | SHIRAISHI ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,657,680	12-2003	Takizawa, Takeshi	349/5
	В	US-5,095,606	03-1992	Barrick, James G.	29/509
	С	US-RE38,194	07-2003	linuma et al.	353/119
	D	US-RE37,836	09-2002	Fujimori et al.	353/119
	Е	US-6,540,360	04-2003	Furuhata et al.	353/31
	F	US-6,906,840	06-2005	Fujimori et al.	359/237
	G	US-			
	Н	US-			·
	1	US-			
	J	US-	·		
	К	US-			
_	٦	US-	•		
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
_	Р					
	Q					
	R	\				
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.